

RADIO TEST REPORT

Test Report No. 16046376S-E-R2

Customer	Sony Group Corporation
Description of EUT	Wireless Noise Canceling Stereo Headset
Model Number of EUT	YY2998
FCC ID	AK8YY2998
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	December 23, 2025
Remarks	Bluetooth (BR / EDR) part(s)

Representative Test EngineerMasahide Ozaki
Engineer**Approved By**Toyokazu Imamura
Engineer

CERTIFICATE 1266.03

- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc.
- ☒ There is no testing item of "Non-accreditation".

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- For any test report referred in this report, the latest version (including any revisions) is always referred to.
- If the latest version is a revision, it replaces the previous version. See the table below for revisions and versions.

REVISION HISTORY

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	16046376S-E	December 1, 2025	-
1	16046376S-E-R1	December 18, 2025	P.10 Added the title "Radiated Spurious Emission test and Conducted Emission". P.11 Added a new Configuration diagram for the Antenna Terminal Conducted Test. P.28 Changed to the correct value. P. 34 Changed the measurement value for 2402 MHz to match the correct value.
2	16046376S-E-R2	December 23, 2025	P.28 Updated to the correct formula.

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	IEC	International Electrotechnical Commission
AC	Alternating Current	IEEE	Institute of Electrical and Electronics Engineers
AFH	Adaptive Frequency Hopping	IF	Intermediate Frequency
AM	Amplitude Modulation	ILAC	International Laboratory Accreditation Conference
Amp, AMP	Amplifier	ISED	Innovation, Science and Economic Development Canada
ANSI	American National Standards Institute	ISO	International Organization for Standardization
Ant, ANT	Antenna	JAB	Japan Accreditation Board
AP	Access Point	LAN	Local Area Network
ASK	Amplitude Shift Keying	LIMS	Laboratory Information Management System
Atten., ATT	Attenuator	MCS	Modulation and Coding Scheme
AV	Average	MRA	Mutual Recognition Arrangement
BPSK	Binary Phase-Shift Keying	N/A	Not Applicable
BR	Bluetooth Basic Rate	NIST	National Institute of Standards and Technology
BT	Bluetooth	NS	No signal detect.
BT LE	Bluetooth Low Energy	NSA	Normalized Site Attenuation
BW	BandWidth	NVLAP	National Voluntary Laboratory Accreditation Program
Cal Int	Calibration Interval	OBW	Occupied Band Width
CCK	Complementary Code Keying	OFDM	Orthogonal Frequency Division Multiplexing
Ch., CH	Channel	OFDMA	Orthogonal Frequency Division Multiple Access
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PP	Preamble Puncturing
DSSS	Direct Sequence Spread Spectrum	PRBS	Pseudo-Random Bit Sequence
EDR	Enhanced Data Rate	PSD	Power Spectral Density
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QAM	Quadrature Amplitude Modulation
EMC	ElectroMagnetic Compatibility	QP	Quasi-Peak
EMI	ElectroMagnetic Interference	QPSK	Quadri-Phase Shift Keying
EN	European Norm	RBW	Resolution Band Width
ERP, e.r.p.	Effective Radiated Power	RDS	Radio Data System
EU	European Union	RE	Radio Equipment
EUT	Equipment Under Test	RF	Radio Frequency
Fac.	Factor	RMS	Root Mean Square
FCC	Federal Communications Commission	RSS	Radio Standards Specifications
FHSS	Frequency Hopping Spread Spectrum	Rx	Receiving
FM	Frequency Modulation	SA, S/A	Spectrum Analyzer
Freq.	Frequency	SG	Signal Generator
FSK	Frequency Shift Keying	SVSWR	Site-Voltage Standing Wave Ratio
GFSK	Gaussian Frequency-Shift Keying	TR	Test Receiver
GNSS	Global Navigation Satellite System	Tx	Transmitting
GPS	Global Positioning System	VBW	Video BandWidth
Hori.	Horizontal	Vert.	Vertical
ICES	Interference-Causing Equipment Standard	WLAN	Wireless LAN

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SECTION 1: Customer Information

Company Name	Sony Group Corporation
Address	1-7-1 Konan Minato-ku, Tokyo, 108-0075 Japan
Contact Person	Kouhei Nagamine

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

SECTION 2: Equipment Under Test (EUT)

2.1 Identification of EUT

Description	Wireless Noise Canceling Stereo Headset
Model Number	YY2998
Serial Number	Refer to SECTION 4.2
Condition	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	October 14, 2025
Test Date	October 15 to October 27, 2025

2.2 Product Description

General Specification

Rating	DC 3.85 V (The EUT is supplied with the power from the internal battery) DC 5 V (The EUT is supplied with the power from the USB port)
Operating temperature	0 deg. C to 40 deg. C

Radio Specification

This report contains data provided by the customer which can impact the validity of results. UL Japan, Inc. is only responsible for the validity of results after the integration of the data provided by the customer. The data provided by the customer is marked "a)" in the table below.

Bluetooth (BR / EDR / Low Energy)

Equipment Type	Transceiver
Frequency of Operation	2402 MHz to 2480 MHz
Type of Modulation	BT: FHSS (GFSK, $\pi/4$ DQPSK, 8 DPSK) BTLE: GFSK
Antenna Gain ^{a)}	4.16 dBi

SECTION 3: Test Summary

3.1 Test Specification

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

*The customer has declared that the EUT has complies with FCC Part 15 Subpart B as SDoC.

3.2 Reference Standards

ANSI/USEMCSC C63.2-2023
ANSI C63.4-2014/C63.4a-2017
ANSI C63.5-2017
ANSI C63.10-2020
ANSI/USEMCSC C63.10/Cor 1-2023
ANSI/USEMCSC C63.10a-2024 (incl. Errata) for ISSED
ANSI C63.25.1-2018
KDB 558074 D01 v05r02
KDB 662911 D01 v02r01 for FCC MIMO device

3.3 Summary of Test Results

Item	Specification	Results	Remarks
Conducted Emission	FCC: Section 15.207 ISED: RSS-Gen 8.8	Complied	-
Carrier Frequency Separation	FCC: Section 15.247(a)(1) ISED: RSS-247 5.1 (b)	Complied	Conducted
20 dB Bandwidth	FCC: Section 15.247(a)(1) ISED: RSS-247 5.1 (a)	Complied	Conducted
Number of Hopping Frequency	FCC: Section 15.247(a)(1)(iii) ISED: RSS-247 5.1 (d)	Complied	Conducted
Dwell time	FCC: Section 15.247(a)(1)(iii) ISED: RSS-247 5.1 (d)	Complied	Conducted
Maximum Peak Output Power	FCC: Section 15.247(b)(1) ISED: RSS-247 5.4 (b)	Complied	Conducted
Spurious Emission & Band Edge Compliance	FCC: Section 15.247(d) ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	Complied	Conducted/ Radiated (above 30 MHz) *1)
Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.			
*1) Radiated test was selected over 30 MHz based on section 15.247(d).			

FCC Part 15.31 (e)

This EUT provides the stable voltage constantly to RF part regardless of input voltage.
Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT.
Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.4 Addition to Standard

Item	Specification	Results	Remarks
99% Occupied Bandwidth	ISED: -	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.5 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.
Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Item	Frequency range	Uncertainty (+/-)
Conducted Emission (AC Mains) LISN	150 kHz to 30 MHz	3.0 dB
Radiated Emission (Measurement distance: 3 m)	9 kHz to 30 MHz	3.3 dB
	30 MHz to 200 MHz	4.8 dB
	200 MHz to 1 GHz	6.1 dB
	1 GHz to 6 GHz	4.7 dB
	6 GHz to 18 GHz	5.3 dB
	18 GHz to 40 GHz	5.5 dB
Radiated Emission (Measurement distance: 1 m)	1 GHz to 18 GHz	5.6 dB
	18 GHz to 40 GHz	5.8 dB

Antenna terminal test	Uncertainty (+/-)
Power Measurement above 1 GHz (Average Detector)	1.3 dB
Power Measurement above 1 GHz (Peak Detector)	1.5 dB
Spurious Emission (Conducted) below 1 GHz	0.93 dB
Conducted Emissions Power Density Measurement 1 GHz to 3 GHz	0.93 dB
Conducted Emissions Power Density Measurement 3 GHz to 18 GHz	3.0 dB
Spurious Emission (Conducted) 18 GHz to 26.5 GHz	2.8 dB
Spurious Emission (Conducted) 26.5 GHz to 40 GHz	2.3 dB
Bandwidth Measurement	0.012 %
Duty Cycle and Time Measurement	0.27 %
Temperature	2.2 deg.C.
Humidity	3.4 %
Voltage	0.92 %

3.6 Test Location

UL Japan, Inc. Shonan EMC Lab.

1-22-3, Megumigaoka, Hiratsuka-shi, Kanagawa-ken 259-1220 Japan

Telephone: +81-463-50-6400

A2LA Certificate Number: 1266.03

(FCC test firm registration number: 626366, ISED lab company number: 2973D / CAB identifier: JP0001)

Test room	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber (SAC1)	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber (SAC2)	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber (SAC3)	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber (SAC4)	8.1 x 5.1 x 3.55	8.1 x 5.1	-
Wireless anechoic chamber 1 (WAC1)	9.5 x 6.0 x 5.4	9.5 x 6.0	3 m
Wireless anechoic chamber 2 (WAC2)	9.5 x 6.0 x 5.4	9.5 x 6.0	3 m
No.1 Shielded room (SR1)	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 Shielded room (SR2)	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.3 Shielded room (SR3)	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 Shielded room (SR4)	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 Shielded room (SR5)	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 Shielded room (SR6)	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.8 Shielded room (SR8)	3.45 x 5.5 x 2.4	3.45 x 5.5	-
No.1 Measurement room (MR1)	2.55 x 4.1 x 2.5	-	-
No.2 Measurement room (MR2)	4.5 x 3.5 x 2.5	-	-
Wireless shielded room 1 (WSR1)	3.0 x 4.5 x 2.7	3.0 x 4.5	-
Wireless shielded room 2 (WSR2)	3.0 x 4.5 x 2.7	3.0 x 4.5	-

3.7 Test Data, Test Instruments, and Test Set Up

Refer to APPENDIX.

SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Mode	Remarks*
Bluetooth (BT)	BR / EDR, Payload: PRBS9
*EUT has the power settings by the software as follows; Power Setting: BR: 51 , EDR: 49 (These setting values are a unitless value (not dBm).) Software: Headset_BT_Test Ver: v002 (Date: 2025.10.14, Storage location: Driven by connected PC) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

Details of Operating Mode(s)

Test Item	Mode	Hopping	Tested Frequency
Conducted Emission, Radiated Spurious Emission (Below 1 GHz)	Tx DH5 *1)	Off	2480 MHz
Radiated Spurious Emission (Above 1 GHz), Conducted Spurious Emission	Tx DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Carrier Frequency Separation	Tx DH5 Tx 3DH5	On	2402 MHz 2441 MHz 2480 MHz
20 dB Bandwidth	Tx DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Number of Hopping Frequency	Tx DH5 Tx 3DH5	On	-
Dwell time	Tx DH1, DH3, DH5 Tx 3DH1, 3DH3, 3DH5	On	-
Maximum Peak Output Power	Tx DH5 Tx 2DH5 Tx 3DH5	Off	2402 MHz 2441 MHz 2480 MHz
Band Edge Compliance (Conducted)	Tx DH5 Tx 3DH5	On ----- Off	2402 MHz 2480 MHz
99% Occupied Bandwidth	Tx DH5 Tx 3DH5	On ----- Off	2402 MHz 2441 MHz 2480 MHz

*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test)

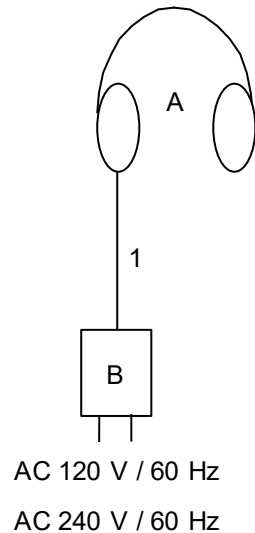
*2DH mode (2Mb/s EDR: pi/4DQPSK) was excluded for other tests than power measurement by using 3DH mode (3 Mb/s EDR: 8DPSK) as a representative.

*It is considered that the non-tested packet type (e.g. inquiry) can be omitted as it is complied with above all the test items based on Bluetooth Core specification.

*1) Conducted emissions and Spurious emissions for frequencies below 1 GHz were limited to the channel that had the highest power during the antenna terminal test, as preliminary testing indicated that changing the operating frequency had no significant impact on the emissions in those frequency bands.

4.2 Configuration and Peripherals

[Radiated Spurious Emission test and Conducted Emission test]



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

*As a result of comparing AC 120 V and AC 240 V at pre-check, conducted emission test was performed with AC 120 V of the worst voltage as representative.

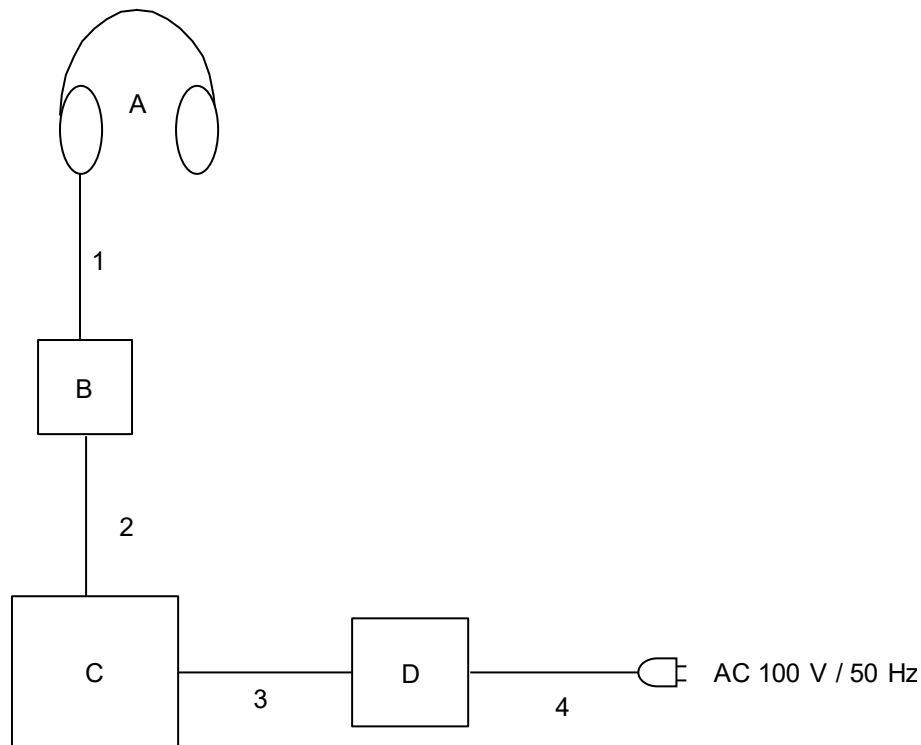
Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Wireless Noise Canceling Stereo Headset	YY2998	1100474	Sony Group Corporation	EUT
B	AC Adaptor	AC-UUD12	19121AQ2017944	Sony Group Corporation	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	USB	1.0	Shielded	Shielded	-

[Antenna Terminal Conducted test]



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Wireless Noise Canceling Stereo Headset	YY2998	1100414	Sony Group Corporation	EUT
B	Jig	-	-	Sony	-
C	Laptop Computer	ThinkPad L580	PF-1PLZHX	LENOVO	-
D	AC Adapter	ADLX45YLC2A	8SSA10E75844C1SG94BG7T0	LENOVO	-

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	USB	1.5	Shielded	Shielded	-
2	USB	0.2	Shielded	Shielded	
3	DC	1.8	Unshielded	Unshielded	
4	AC	0.9	Unshielded	Unshielded	

SECTION 5: Conducted Emission

Test Procedure and Conditions

EUT was placed on the platform of nominal size, 0.8 m by 1.6 m, raised 0.8 m above the conducting ground plane.

The rear of the platform was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals was aligned and flushed with rear of the platform. All other surfaces of the platform were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN).

For the tests on EUT with other peripherals (as a whole system)

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Shielded Room.

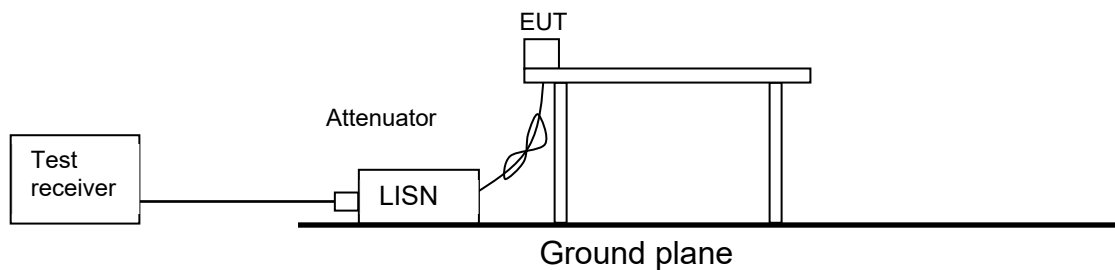
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Test results are rounded off and limit are rounded down, so some differences might be observed.

Detector	: QP and CISPR AV
Measurement Range	: 0.15 MHz to 30 MHz
Test Data	: APPENDIX
Test Result	: Pass

Figure 1: Test Setup



SECTION 6: Radiated Spurious Emission

Test Procedure

[For below 1 GHz]

EUT was placed on the platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on the platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane. Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

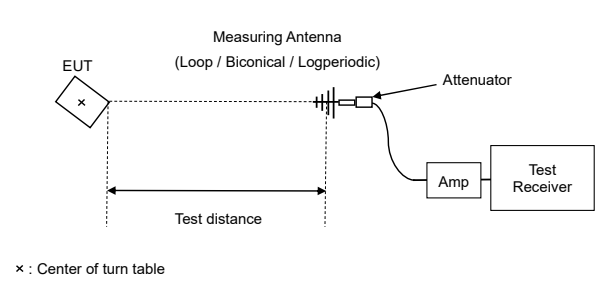
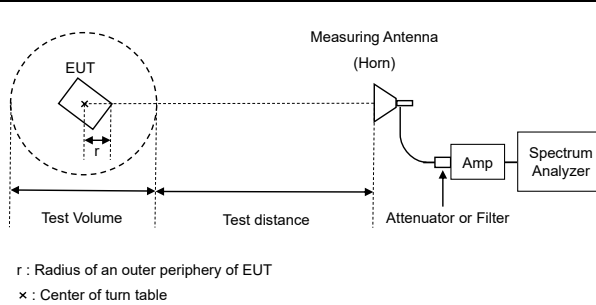
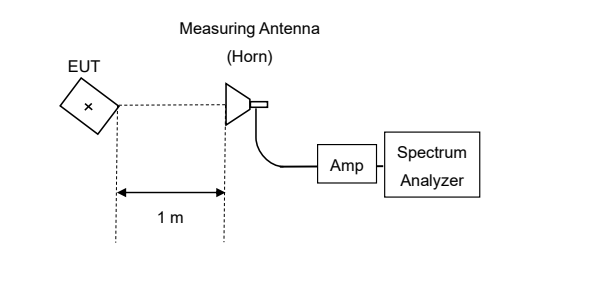
In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9 (ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).

It was measured with the settings below based on ANSI C63.10.

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces Duty factor was added to the results	RBW: 100 kHz VBW: 300 kHz

Figure 2: Test Setup

Below 1 GHz	
 x : Center of turn table	Test Distance: 3 m
1 GHz to 10 GHz	
 r : Radius of an outer periphery of EUT x : Center of turn table	Distance Factor: $20 \times \log (3.91 \text{ m}^* / 3.0 \text{ m}) = 2.29 \text{ dB}$ *(Test Distance + SVSWR Volume / 2) - r = 3.91 m Test Distance: 3 m SVSWR Volume: 2 m (SVSWR Volume has been calibrated based on CISPR 16-1-4.) r: 0.095 m
10 GHz to 26.5 GHz	
 x : Center of turn table	Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.54 \text{ dB}$ *Test Distance: 1 m

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test results are rounded off and limit are rounded down, so some differences might be observed.

Measurement Range : 30 MHz to 26.5 GHz
Test Data : APPENDIX
Test Result : Pass

SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument Used
20 dB Bandwidth	3 MHz	30 kHz	100 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold *1)	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/Average *2)	-	Power Meter (Sensor: 160 MHz BW)
Carrier Frequency Separation	3 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	100 kHz, 1 MHz	300 kHz, 3 MHz	As necessary capture the entire dwell time per hopping channel	Peak	Clear Write	Spectrum Analyzer
Conducted Spurious Emission *3) *4)	9 kHz to 150 kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150 kHz to 30 MHz	10 kHz	30 kHz				
	30 MHz to 25 GHz	100 kHz	300 kHz				
Conducted Spurious Emission Band Edge compliance	2390 MHz to 2403 MHz 2479 MHz to 2493.5 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer

*1) The measurement was performed with Max Hold since the duty cycle was not 100 %. Peak hold was applied as Worst-case measurement.

*2) Reference data

*3) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

① Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.

(9 kHz -150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 10 kHz)

② Then, wide-band noise near the limit was checked separately, however the noise was low enough as shown in the chart.

(9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 10 kHz).

③ Then, wide-band noise near the limit was checked separately and the noise was detected as shown in the chart, and therefore, Radiated Emission below 30 MHz was performed.

*4) The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency 9 kHz resulted in a level of 45.5 dBuV/m, which is equivalent to $45.5 - 51.5 = -6.0$ dBuA/m, which has the same margin, 3 dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.

Test results are rounded off and limit are rounded down, so some differences might be observed.
The equipment and cables were not used for factor 0 dB of the data sheets.

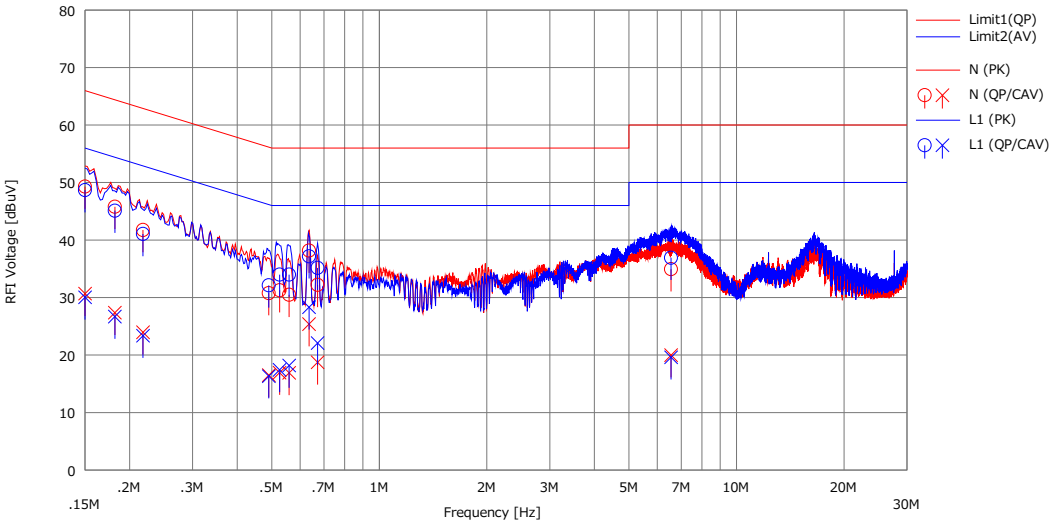
Test Data : APPENDIX
Test Result : Pass

APPENDIX 1: Test data

Conducted Emission

Mode	Tx, Hopping Off, DH5 2480 MHz (AC 120 V/ 60 Hz)			
Date	Test site	Temperature	Humidity	Engineer
October 27, 2025	SR8	24 deg. C	54 % RH	Masahide Ozaki

Limit : FCC_Part 15 subpart C(15.207)



No.	Freq. [MHz]	Reading		C.Fac	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<CAV> [dBuV]		<QP> [dBuV]	<CAV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.15000	34.14	15.52	15.15	49.29	30.67	66.00	56.00	16.7	25.3	N	
2	0.18190	30.62	12.21	15.16	45.78	27.37	64.40	54.40	18.6	27.0	N	
3	0.21800	26.58	8.81	15.16	41.74	23.97	62.89	52.89	21.1	28.9	N	
4	0.49060	15.60	1.33	15.17	30.77	16.50	56.16	46.16	25.3	29.6	N	
5	0.52610	16.11	1.76	15.17	31.28	16.93	56.00	46.00	24.7	29.0	N	
6	0.55920	15.31	1.72	15.17	30.48	16.89	56.00	46.00	25.5	29.1	N	
7	0.63580	22.99	10.20	15.18	38.17	25.38	56.00	46.00	17.8	20.6	N	
8	0.67160	17.04	3.56	15.17	32.21	18.73	56.00	46.00	23.7	27.2	N	
9	6.55920	19.43	4.47	15.51	34.94	19.98	60.00	50.00	25.0	30.0	N	
10	0.15000	33.54	14.89	15.14	48.68	30.03	66.00	56.00	17.3	25.9	L1	
11	0.18190	29.95	11.54	15.15	45.10	26.69	64.40	54.40	19.3	27.7	L1	
12	0.21800	25.91	8.21	15.16	41.07	23.37	62.89	52.89	21.8	29.5	L1	
13	0.49060	16.97	1.17	15.15	32.12	16.32	56.16	46.16	24.0	29.8	L1	
14	0.52610	18.83	2.27	15.15	33.98	17.42	56.00	46.00	22.0	28.5	L1	
15	0.55920	18.83	3.01	15.16	33.99	18.17	56.00	46.00	22.0	27.8	L1	
16	0.63580	22.01	13.14	15.17	37.18	28.31	56.00	46.00	18.8	17.6	L1	
17	0.67160	19.99	6.91	15.17	35.16	22.08	56.00	46.00	20.8	23.9	L1	
18	6.55920	21.50	4.19	15.42	36.92	19.61	60.00	50.00	23.0	30.3	L1	

Calculation: Result[dBuV]=Reading[dBuV]+C.Fac(LISN(AMN)+Cable+ATT)[dB]
LISN(AMN): LIMS ID 145539

20 dB Bandwidth, 99 % Occupied Bandwidth and Carrier Frequency Separation

Mode	Hopping On / Off
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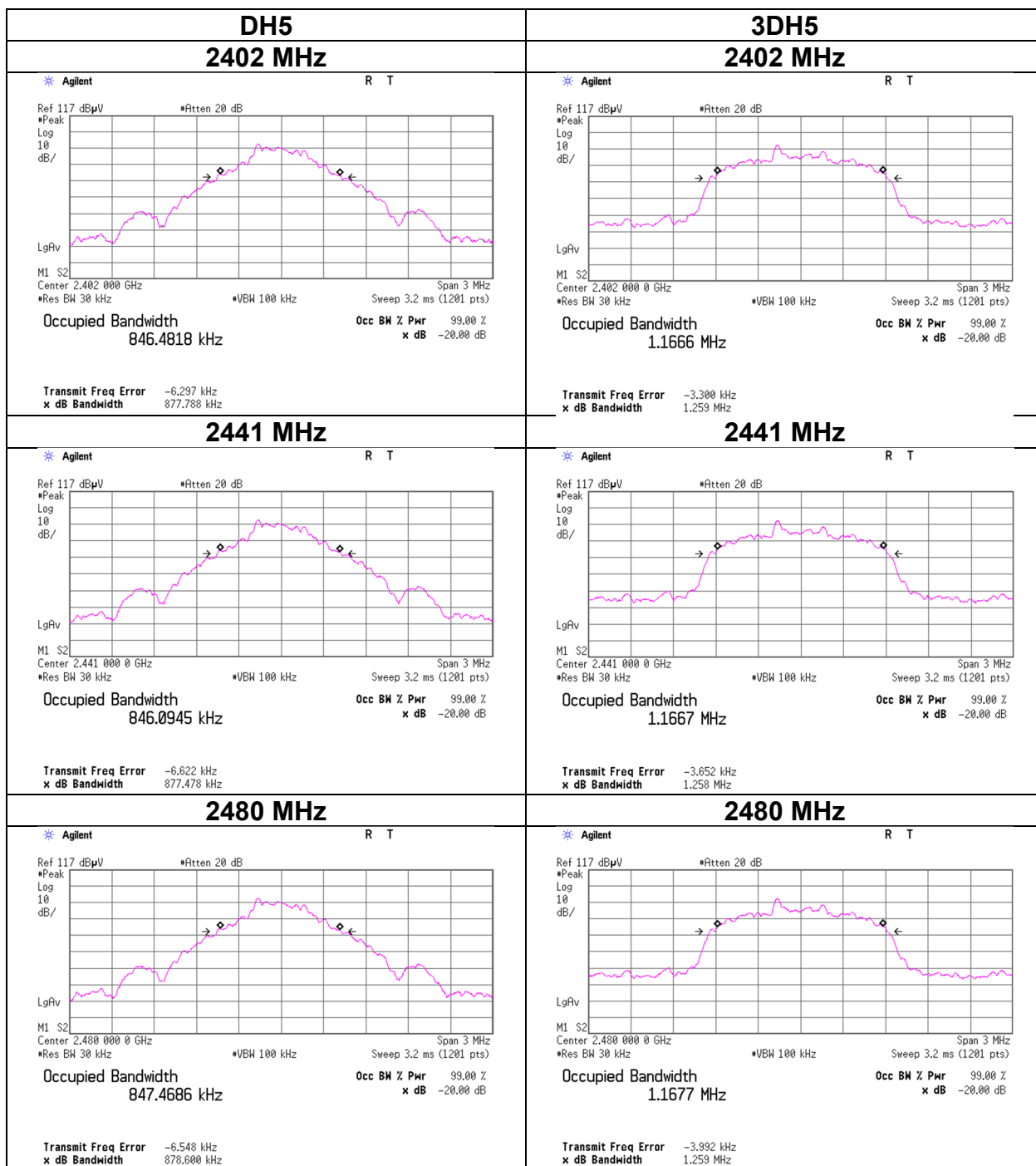
Date	Test site	Temperature	Humidity	Engineer
October 27, 2025	SR5	24 deg. C	60 % RH	Takayuki Kobayashi

Mode	Freq. [MHz]	20 dB Bandwidth [MHz]	99 % Occupied Bandwidth [kHz]	Carrier Frequency Separation [MHz]	Limit for Carrier Frequency separation [MHz]
DH5	2402.0	0.878	846.5	1.010	>= 0.585
DH5	2441.0	0.877	846.1	1.000	>= 0.585
DH5	2480.0	0.879	847.5	1.003	>= 0.586
DH5	Hopping On	-	78658.0	-	-
3DH5	2402.0	1.259	1166.6	1.003	>= 0.839
3DH5	2441.0	1.258	1166.7	1.000	>= 0.839
3DH5	2480.0	1.259	1167.7	1.000	>= 0.839
3DH5	Hopping On	-	78721.3	-	-

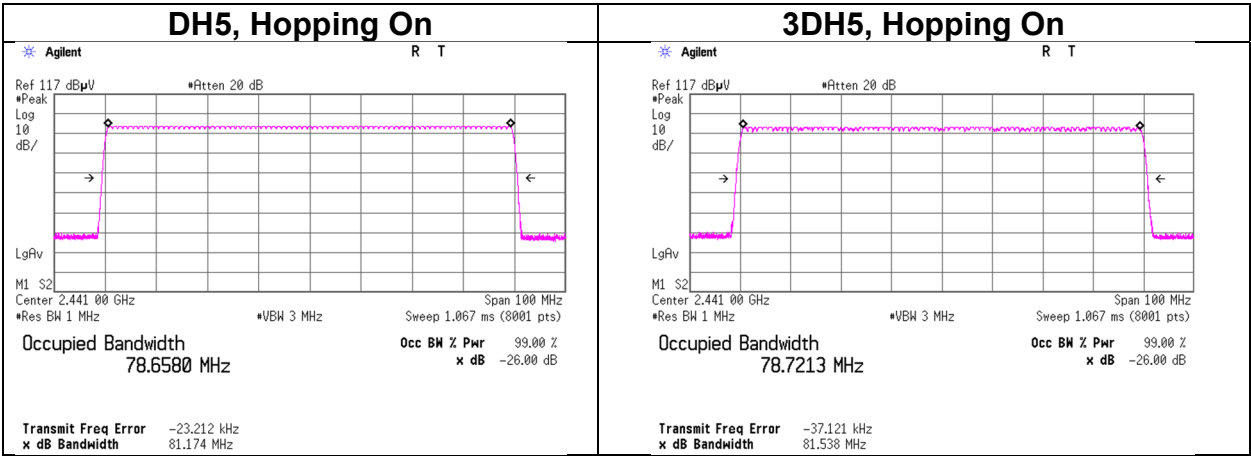
Limit: Two-thirds of 20 dB Bandwidth or 25 kHz (whichever is greater).

No limit applies to 20 dB Bandwidth.

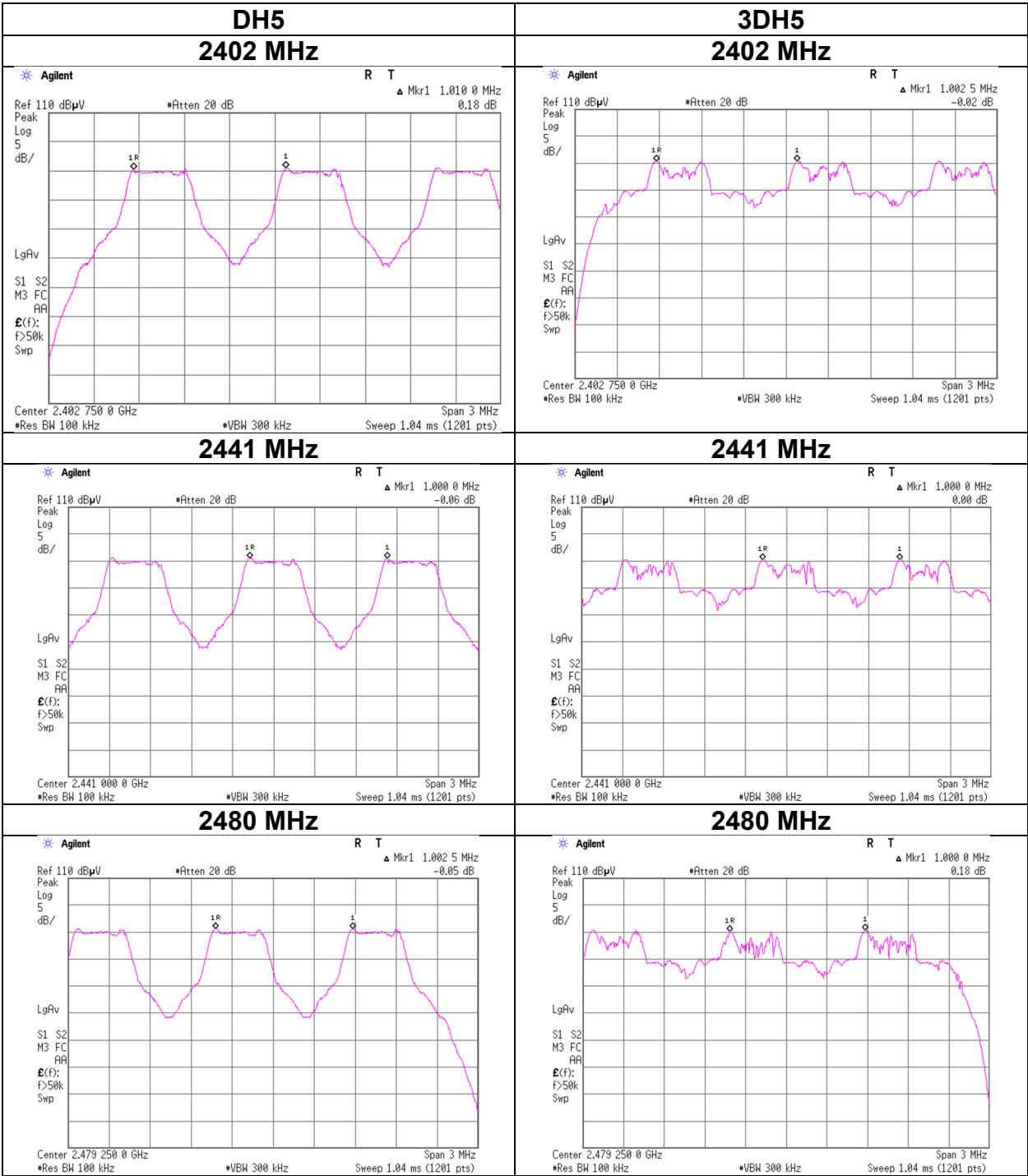
20 dB Bandwidth and 99 % Occupied Bandwidth



20 dB Bandwidth and 99 % Occupied Bandwidth



Carrier Frequency Separation



Number of Hopping Frequency

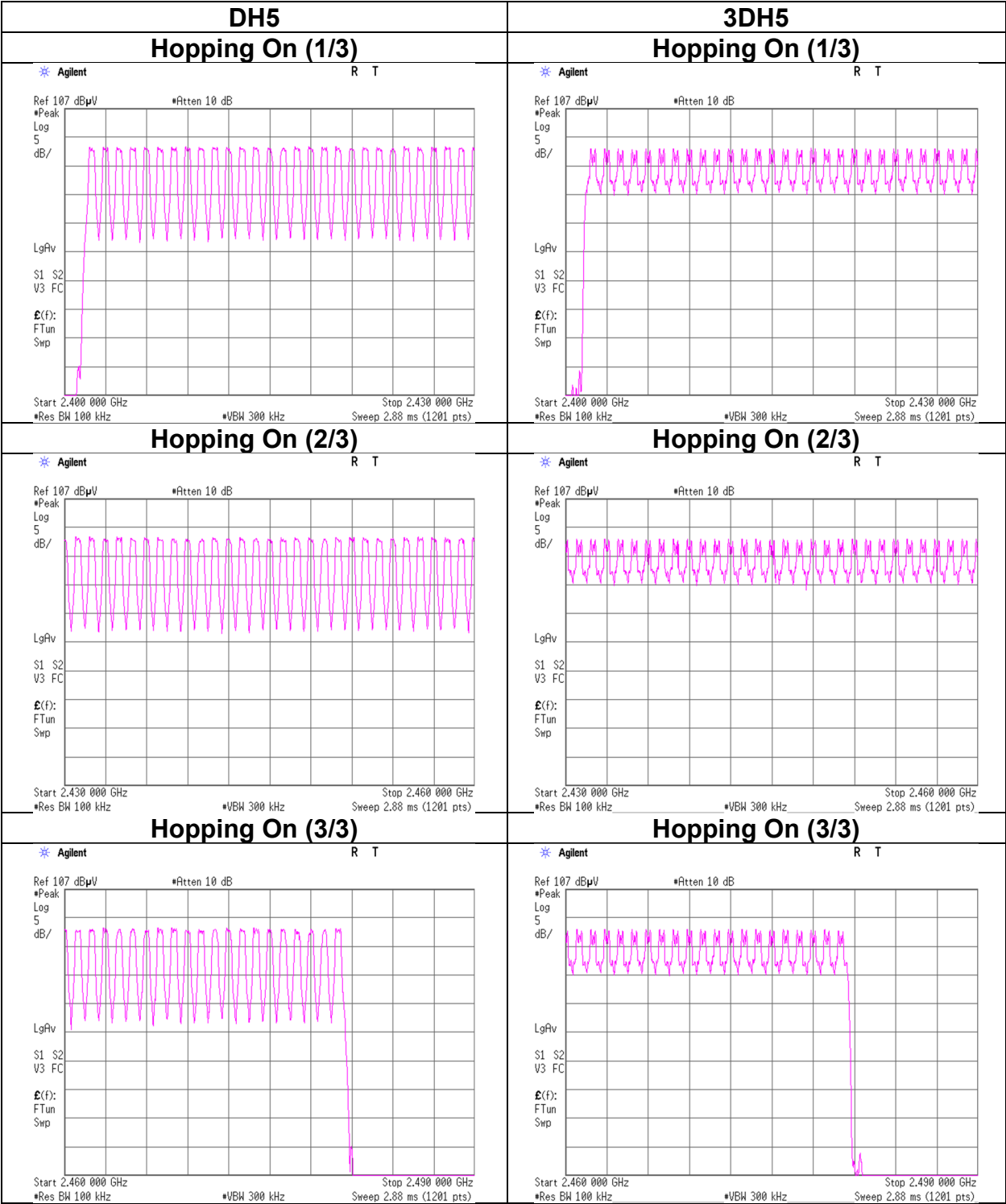
Mode	Tx, Hopping On			
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Date	Test site	Temperature	Humidity	Engineer
October 20, 2025	SR5	25 deg. C	56 % RH	Takayuki Kobayashi

Mode	Number of channel [channels]	Limit [channels]
DH5	79	>= 15
3DH5	79	>= 15

Test was not performed at AFH mode whose number of hopping channel is 20 channels because this Bluetooth radio is in compliance of Bluetooth Specification.

Number of Hopping Frequency



Dwell time

Mode	Tx, Hopping On
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Date	Test site	Temperature	Humidity	Engineer
October 20, 2025	SR5	25 deg. C	65 % RH	Takayuki kobayashi

Mode	Number of transmission in a 31.6 (79 Hopping x 0.4)	Length of transmission [ms]	Result [ms]	Limit [ms]
DH1	51.0 times / 5 s x 31.6 s = 323 times	0.422	136	400
DH3	26.0 times / 5 s x 31.6 s = 165 times	1.677	277	400
DH5	17.0 times / 5 s x 31.6 s = 108 times	2.914	315	400
3DH1	50.8 times / 5 s x 31.6 s = 322 times	0.425	137	400
3DH3	25.8 times / 5 s x 31.6 s = 164 times	1.666	273	400
3DH5	16.8 times / 5 s x 31.6 s = 107 times	2.922	313	400

Sample Calculation

Result = Number of transmission x Length of transmission

* Also compliance with the requirements for minimum number of channels(20 hops) made by Bluetooth AFH Specification.

*Average data of 5 tests.

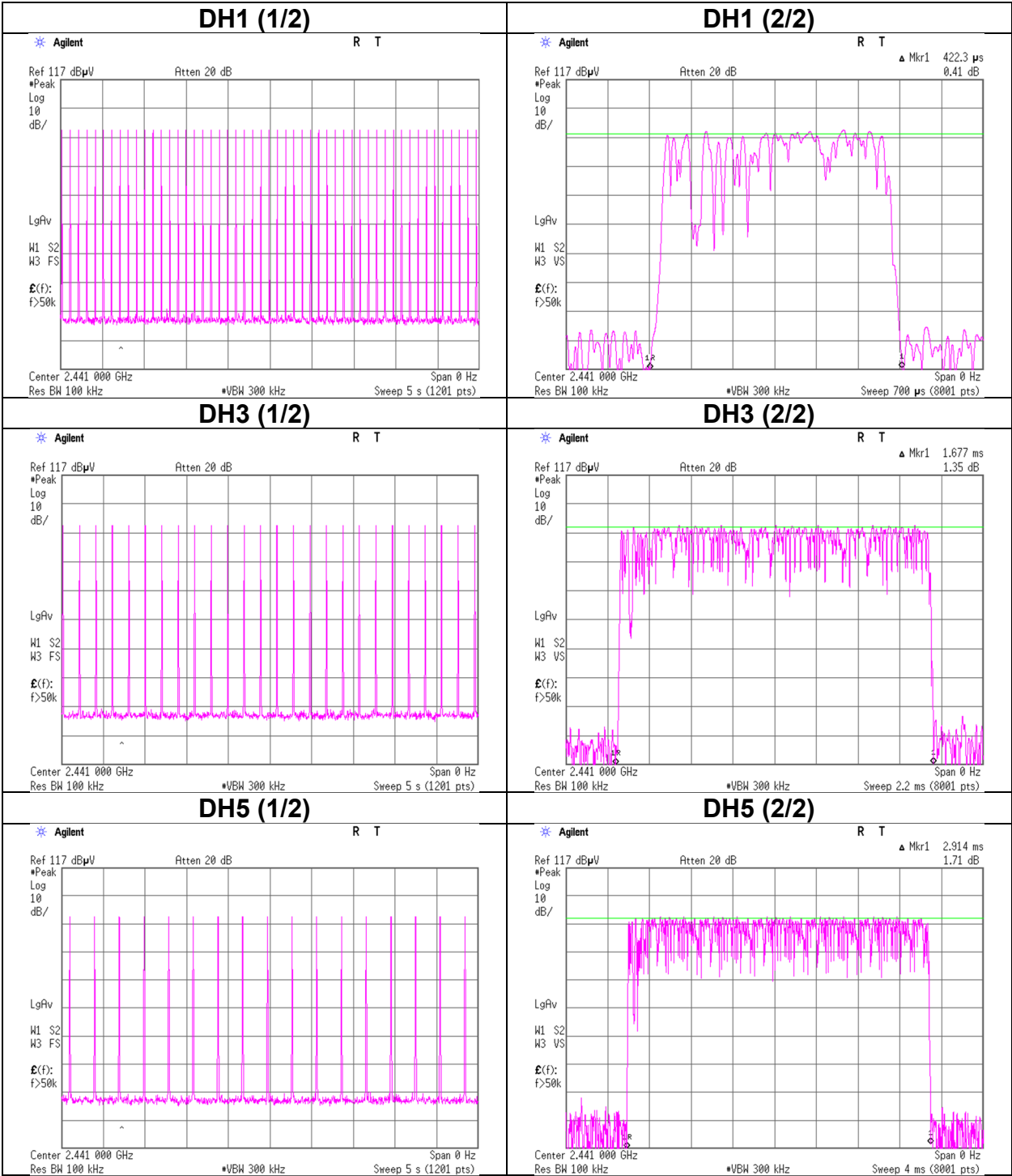
Mode	Sampling [times]					Average [times]
	1	2	3	4	5	
DH1	51	51	51	51	51	51
DH3	26	26	26	26	26	26
DH5	17	17	17	17	17	17
3DH1	51	51	51	51	50	50.8
3DH3	25	26	26	26	26	25.8
3DH5	17	17	16	17	17	16.8

Sample Calculation

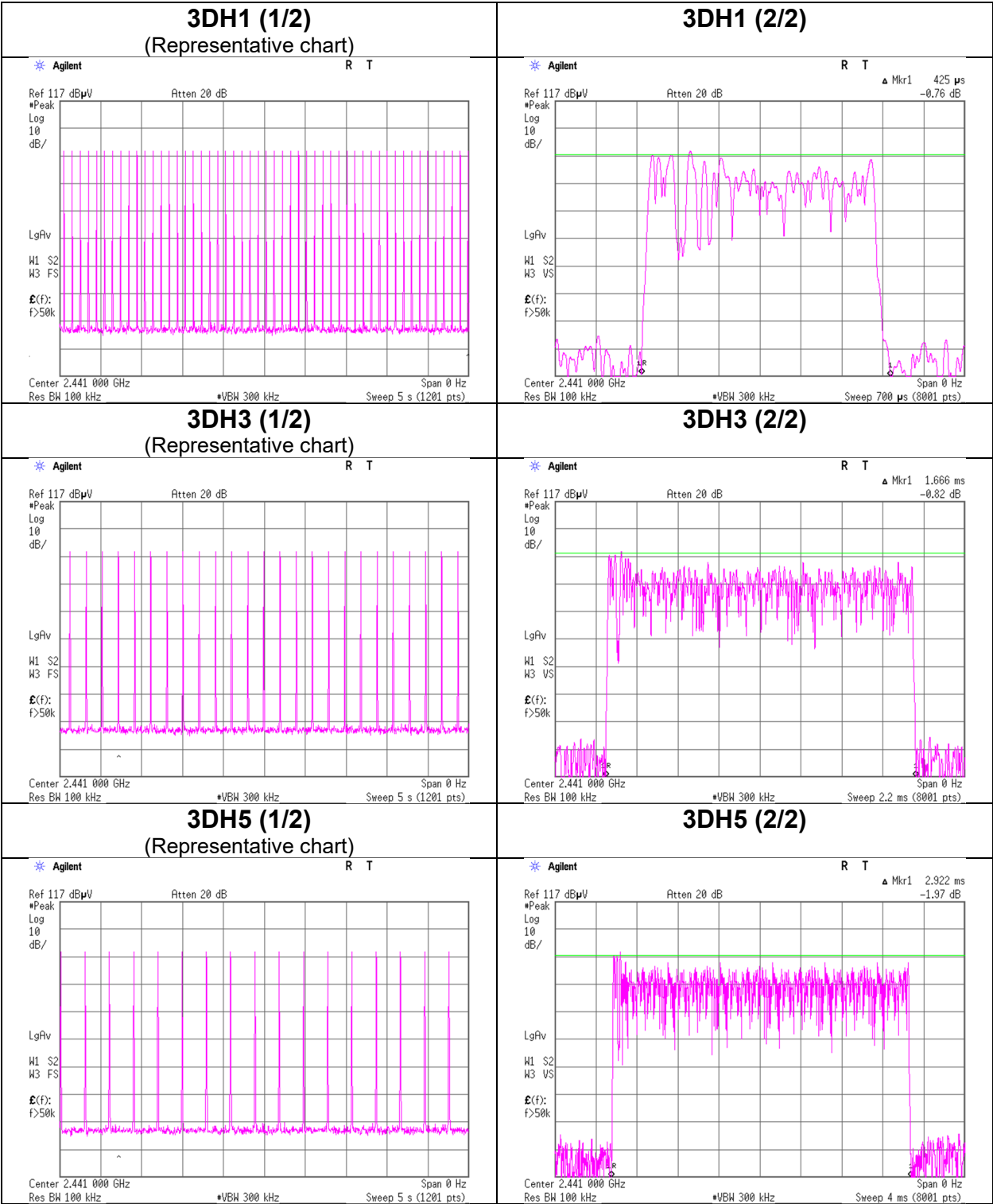
Average = Summation (Sampling 1 to 5) / 5

This device complies with the Bluetooth protocol for FHSS operation, employing a pseudo random channel selection and hopping rate to ensure that the occupancy time in $N \times 0.4$ s, where N is the number of channels being used in the hopping sequence ($20 \leq N \leq 79$), is always less than 0.4 s regardless of packet size. This is confirmed in the test report for N = 79.

Dwell time



Dwell time



Maximum Peak Output Power

Mode	Tx, Hopping Off
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Date	Test site	Temperature	Humidity	Engineer
October 16, 2025	SR5	27 deg. C	52 % RH	Masahide Ozaki

Maximum peak output power

Maximum Peak Output Power					Conducted Power					e.i.r.p. for RSS-247					
Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
DH5	2402	-6.28	1.19	9.95	4.86	3.06	20.97	125	16.11	4.16	9.02	7.98	36.02	4000	27.00
DH5	2441	-6.32	1.19	9.95	4.83	3.04	20.97	125	16.14	4.16	8.99	7.92	36.02	4000	27.04
DH5	2480	-6.29	1.20	9.95	4.86	3.06	20.97	125	16.11	4.16	9.02	7.98	36.02	4000	27.00
2DH5	2402	-6.56	1.19	9.95	4.58	2.87	20.97	125	16.39	4.16	8.74	7.48	36.02	4000	27.28
2DH5	2441	-6.62	1.19	9.95	4.53	2.83	20.97	125	16.44	4.16	8.69	7.39	36.02	4000	27.34
2DH5	2480	-6.59	1.20	9.95	4.56	2.86	20.97	125	16.41	4.16	8.72	7.45	36.02	4000	27.30
3DH5	2402	-6.38	1.19	9.95	4.76	2.99	20.97	125	16.21	4.16	8.92	7.80	36.02	4000	27.10
3DH5	2441	-6.48	1.19	9.95	4.67	2.93	20.97	125	16.30	4.16	8.83	7.63	36.02	4000	27.20
3DH5	2480	-6.49	1.20	9.95	4.66	2.93	20.97	125	16.31	4.16	8.82	7.62	36.02	4000	27.20

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

Test was not performed at AFH mode, because the decrease of number of channel (min: 20 ch) at AFH mode does not influence on the output power and bandwidth of the EUT.

As this device had AFH mode and frequency separation could not meet the requirement of over 20 dB BW without 2/3 relaxation, 125 mW power limit was applied to it.

Average Output Power (Reference data for RF Exposure)

Mode	Tx, Hopping Off			
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Date	Test site	Temperature	Humidity	Engineer
October 16, 2025	SR5	27 deg. C	52 % RH	Masahide Ozaki

Average power (Reference data for RF Exposure / SAR testing)

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
					[dBm]	[mW]		[dBm]	[mW]
DH5	2402	-7.69	1.19	9.95	3.45	2.21	1.15	4.60	2.88
DH5	2441	-7.72	1.19	9.95	3.43	2.20	1.15	4.57	2.87
DH5	2480	-7.68	1.20	9.95	3.47	2.22	1.15	4.62	2.90
2DH5	2402	-10.24	1.19	9.95	0.90	1.23	1.16	2.06	1.61
2DH5	2441	-10.31	1.19	9.95	0.84	1.21	1.16	1.99	1.58
2DH5	2480	-10.26	1.20	9.95	0.89	1.23	1.16	2.05	1.60
3DH5	2402	-10.23	1.19	9.95	0.91	1.23	1.16	2.06	1.61
3DH5	2441	-10.30	1.19	9.95	0.85	1.21	1.16	2.00	1.59
3DH5	2480	-10.25	1.20	9.95	0.90	1.23	1.16	2.06	1.61

Sample Calculation:

Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

Result (Burst power average) = Result (Time average) + Duty factor

*The equipment and cables were not used for factor 0 dB of the data sheets.